

Application/Control No.	Applicant(s)/Patent under Reexamination
10/783,965	HAMANN ET AL.
Examiner	Art Unit
David M. Fenstermacher	3682

SEARCHED				
Class	Subclass	Date	Examiner	
74	424.76			
<u>-</u>	424.5			
	424.71			
	424.6			
	424.5			
	426	7/15/2007	DMF	
Updated		11/16/2007	DMF	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXM	
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